Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/729,262	MURAKAWA, YASUSHI	
Examiner	Art Unit	-
Ellen C. Tran	2134	

	SEARCHED				
Class	Subclass	Date	Examiner		
713	201	6/1/2005	ECT		
713	153	6/1/2005	ECT		
			-		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	6/1/2005	ECT		